

**Search Notes**

Application No.

10/629,896

Examiner

Patrick Miller

Applicant(s)

KARIKOMI, TAKAAKI

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
363	34,37,21.1 ,21.18,39- 41,74	12/27/2004	PM
318	800,801	12/27/2004	PM
318	807,809	12/27/2004	PM
318	812,811	12/27/2004	PM
318	806	12/27/2004	PM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
vector control; phase angle detector/ion; axis; long/short/d/g axis; locus; superimposing; separating; cross product; ratio	12/27/2004	PM